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(3) \$

Schematic diagram

NCE)

NCE15H10 XXXXX

Marking and pin assignment

GDS TO-220-3L top view

(1) GO

NCE N-Channel Enhancement Mode Power MOSFET

Description

The NCE15H10 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use in PWM, load switching and general purpose applications.

General Features

- V_{DS} =150V,I_D =100A
 - $R_{DS(ON)} < 12m\Omega @ V_{GS} = 10V$ (Typ:9.8m Ω)
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Special designed for convertors and power controls
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

Application

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

100% UIS TESTED!

100% ΔVds TESTED!

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
NCE15H10	NCE15H10	TO-220-3L	-	-	-

Absolute Maximum Ratings (Tc =25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	VDS	150	V	
Gate-Source Voltage	Vgs	±20	V	
Drain Current-Continuous	Ι _D	100	А	
Drain Current-Continuous(Tc=100 ℃)	l₀ (100°C)	70	А	
Pulsed Drain Current	I _{DM}	400	A	
Maximum Power Dissipation	PD	370	W	
Derating factor		2.47	W/℃	
Single pulse avalanche energy ^(Note 5)	Eas	1100	mJ	
Operating Junction and Storage Temperature Range	TJ,TSTG	-55 To 175	°C	



Thermal Characteristic

Thermal Resistance, Junction-to-Case(Note 2)	R _{θJC}	0.41	°C/W
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Electrical Characteristics (Tc=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Мах	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250µA	150	170	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =150V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250µA	2	3.2	4	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =40A	-	9.8	12	mΩ
Forward Transconductance	g fs	V _{DS} =25V,I _D =40A	150	-	-	S
Dynamic Characteristics (Note4)			1			
Input Capacitance	Clss			11800	-	PF
Output Capacitance	Coss		-	365	-	PF
Reverse Transfer Capacitance	Crss	F=1.0MHZ	-	294	-	PF
Switching Characteristics (Note 4)		-				
Turn-on Delay Time	t _{d(on)}		-	32.5	-	nS
Turn-on Rise Time	tr	VDD=75V, RL=1.5Ω	-	30	-	nS
Turn-Off Delay Time	t _{d(off)}	V _{DS} =75V,V _{GS} =0V, F=1.0MHz VDD=75V, RL=1.5Ω ,RG=2.5Ω,VGS=10V V _{DS} =75V,I _D =20A, V _{GS} =10V		113	-	nS
Turn-Off Fall Time	tf		-	48	-	nS
Total Gate Charge	Qg)/ <u>75</u>)// 00A	-	280	-	nC
Gate-Source Charge	Q _{gs}		-	50	-	nC
Gate-Drain Charge	Q _{gd}	V _{GS} =10V	-	93	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =100A	-	-	1.2	V
Diode Forward Current (Note 2)	ls		-	-	100	A
Reverse Recovery Time	t _{rr}	Tj=25℃,I _F =100A,di/dt=100A/µs	-	55	-	nS
Reverse Recovery Charge	Qrr	(Note3)	-	182	-	nC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligib	le (turn	on is dom	ninated by	LS+LD)

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.

2. Surface Mounted on FR4 Board, $t \le 10$ sec.

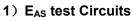
3. Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 2%.

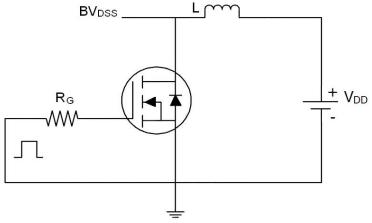
4. Guaranteed by design, not subject to production

5. EAS condition: Tj=25 $^\circ C$,V_DD=50V,V_G=10V,L=0.5mH,Rg=25 Ω

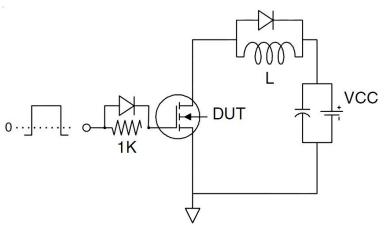


Test circuit

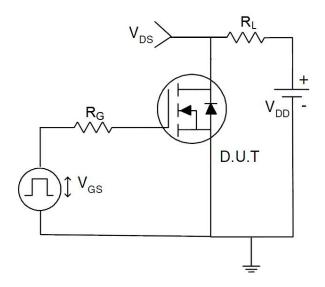




2) Gate charge test Circuit:

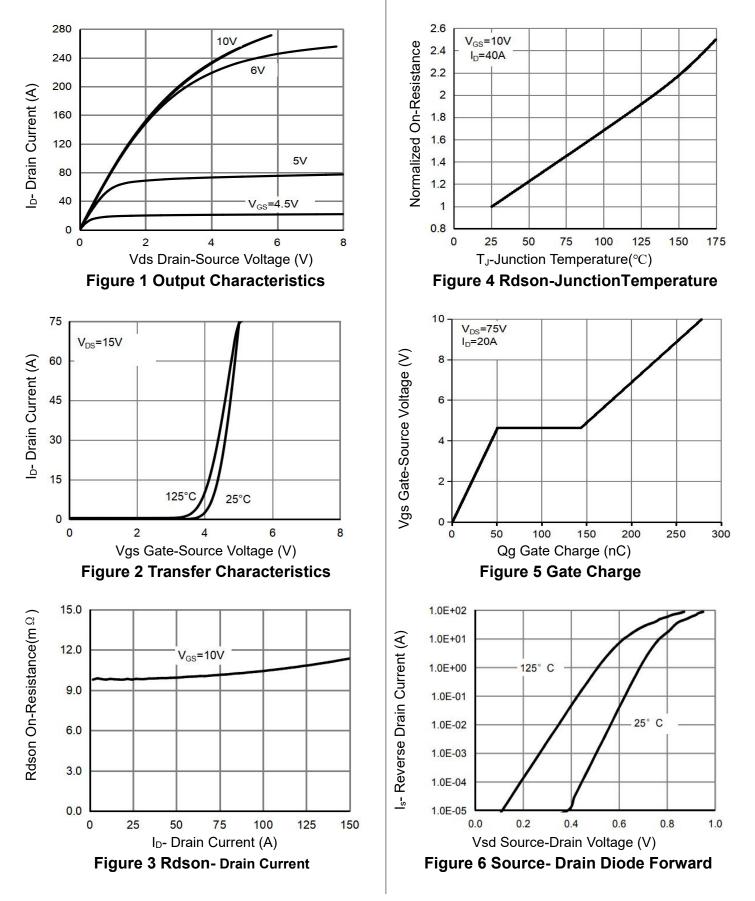


3) Switch Time Test Circuit:



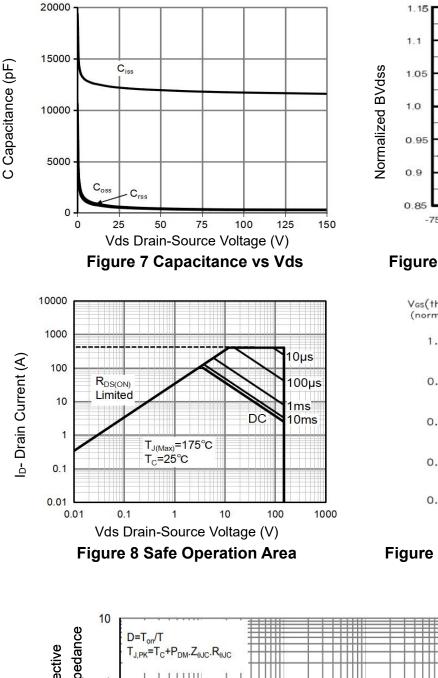


Typical Electrical and Thermal Characteristics (Curves)





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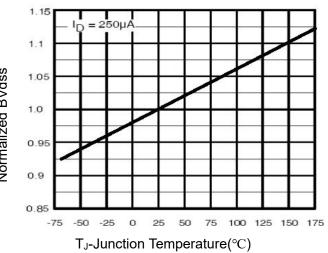


Figure 9 BV_{DSS} vs Junction Temperature

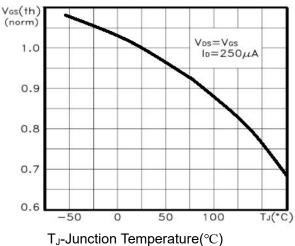
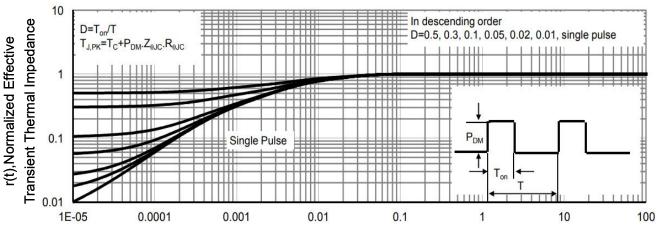
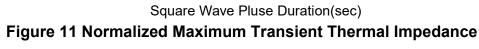


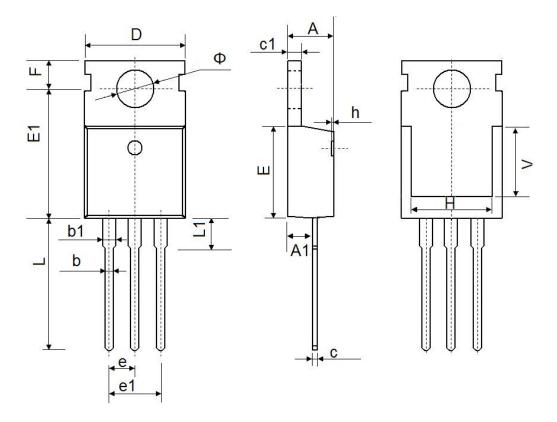
Figure 10 V_{GS(th)} vs Junction Temperature







TO-220-3L Package Information



Symbol	Dimensions	In Millimeters	Dimensions In Inches		
	Min.	Max.	Min.	Max.	
А	4.400	4.600	0.173	0.181	
A1	2.250	2.550	0.089	0.100	
b	0.710	0.910	0.028	0.036	
b1	1.170	1.370	0.046	0.054	
С	0.330	0.650	0.013	0.026	
c1	1.200	1.400	0.047	0.055	
D	9.910	10.250	0.390	0.404	
E	8.9500	9.750	0.352	0.384	
E1	12.650	12.950	0.498	0.510	
е	2.540 TYP.		0.100 TYP.		
e1	4.980	5.180	0.196	0.204	
F	2.650	2.950	0.104	0.116	
Н	7.900	8.100	0.311	0.319	
h	0.000	0.300	0.000	0.012	
L	12.900	13.400	0.508	0.528	
L1	2.850	3.250	0.112	0.128	
V	7.500 REF.		0.295 REF.		
Ф	3.400	3.800	0.134	0.150	



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